Spin Transfer Torque Point Contacts

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Outline

Spin torque & applications

- MRAM, racetrack memory, spin torque oscillator (STO)
- Noise source in HD read heads
- Point contacts : vortex oscillations
- Point contacts : spin wave generation
- Dynamics in magnetic semiconductors



Spintronics ?

- Key technology behind magnetic data storage
 - Ultra-sensitive read heads drive Moore's law in HD data storage
- Many other (potential) applications
 - Sensors: biosensors, automotive, positioning, ...
 - MRAM
 - Spin-torque oscillators
 - "Dirty" environments (radiation hardness, ...)





MRAM



Figure 2. Photomicrographs showing the increasing density of prototype magnetic random-access memory (MRAM) chips. (a) IBM 1 mm \times 1.5 mm, 1 kbit chip with a 5.4- μ m² twin cell in 0.25- μ m technology with approximately 3–10-ns access time (from Reference 22, with permission). (b) Motorola 3.9 mm \times 3.2 mm, 256 kbit chip with 7.1- μ m² cell in 0.6- μ m technology with 50-ns access time (from Reference 23, with permission). (c) Motorola 4.25 mm \times 5.89 mm, 1 Mbit chip with 7.1- μ m² cell in 0.6- μ m technology with 50-ns access time (from Reference 24, with permission). (d) Motorola 4.5 mm \times 6.3 mm, 4 Mbit chip with 1.55- μ m² cell in 180-nm technology with 25-ns access time (from Reference 17, with permission). (e) IBM 7.9 mm \times 10 mm, 16 Mbit chip with 1.42- μ m² cell in 180-nm technology with 30-ns access time (adapted from Reference 21, with permission).

- Cross-point
 - Failed
- Toggle MRAM
 - Up to ~2006: steady increase in size of demonstrators
 - Only 1 product (Motorola / Freescale / Everspin): scaling issues

Spin torque MRAM

- Scaling much better
- Industry side: is picking up momentum after a few years of silence

Domain wall motion based: Racetrack memory

S. Parkin (IBM), Patent US 6,955,926 B2 (2005)



Session II (Thursday): Nanowires & Domain Wall Propagation

Low-cost tunable radio on a Si chip

NEEDED: -15 dBm (3uW) output power



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Competition: LC based VCO above IC



5 GHz VCO On 90 nm



High quality coil Thick Cu High k dielectric

UWB VCO on 0.35 um



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Competition: RF-MEMS



RF MEMS Resonators in Poly SiGe (IMEC)

- Lower processing temperature (400C) compared to poly-Si on top of IC possible !!!
- Electromechanical properties very similar to poly-Si High quality factors (3000)



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Vacuum package

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Compared to existing oscillator technologies

	VCO-LC	VCO- L high K	RF MEMS	VCO- STO
f = 5 - 10 GHz				
Size	500 um ²	1 mm ²	1 mm ²	1 um ²
Q	18 (classical on chip inductor)	100 (enhanced inductor)	1000	> 1000
Output power/	- 10 dBm	0 dBm	0 dBm	>- 15 dBm
Phase noise and long term stability	-117 dBc @ 400 kHz	-115 dBc	-110 dBc	< -110 dBc?
Power consumption	8 mA @ 2.5V	0.4 mA @ 0.82 V	35 mA @ 3.3V	1-5 mA @ 1V
Tunable range	20 %	10 %	1 %	10-100%
Agility	microseconds	microseconds		Nanoseconds

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Spintronics ?

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- Many other applications
 - Sensors (biosensors, automotive, ...)
 - MRAM
 - Spin-torque oscillators
 - "Dirty" environments (radiation hardness, ...)





Noise in GMR sensors: thermally excited FMR

J. C. Jury, *"Measurement and Analysis of Noise Sources in GMR Sensors Up to 6 GHz,"* IEEE Trans. Magn. **38**, 3545 (2002). (Stanford & IBM)



Fig. 1. Voltage noise spectral density for a typical GMR sensor (nonsaturated and saturated). Solid traces indicate actual measured data. Traces 1 (nonsaturated) and 2 (saturated) indicate 1/f noise. Traces 3 (nonsaturated) and 4 (saturated) indicate thermal (electrical and magnetic) fluctuation noise. Dotted lines extrapolate these traces to their intercept points. Trace 5 indicates the resonance in the magnetic fluctuation noise (at about 5 GHz).



Fig. 5. Measured voltage noise density for saturated type B sensors at various bias currents. Solid line: measured noise at specified bias current. Dashed line: expected noise from measured ac resistance.

Also: Y. Zhou, "Experimental observations of thermally excited ferromagnetic resonance and mag-noise spectra in spin valve heads," MMM-46 (Seattle, 2001), Paper CB-06.

Noise in GMR sensors: ... and more

J.-G. Zhu, *"Current Induced Noise in CPP Spin Valves,"* IEEE Trans. Magn. **40**, 2323 (2004). (Carnegie Mellon & Headway Technologies)

I. INTRODUCTION

C URRENT perpendicular-to-plane (CPP) read head designs, such as magnetic tunnel junction (MTJ), spin-valve [1], and giant magnetoresistive (GMR) multilayer [2] designs can potentially provide high readback amplitude at deep submicrometer track widths. CPP spin valves are of particular interest because they have low Johnson noise and are shot noise free, in comparison with MTJ read heads.

in a CPP spin-valve head, the spin transfer effect can induce a substantial magnetic noise with a pronounced 1/fspectral content if a critical current density is exceeded

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Noise in GMR sensors: ... and more

J.-G. Zhu, *"Current Induced Noise in CPP Spin Valves,"* IEEE Trans. Magn. **40**, 2323 (2004). (Carnegie Mellon & Headway Technologies)



Fig. 1. Cross-section transmission electron micrograph of the CPP read sensor stack, patterned into a 95×95 nm² square at the free layer level (left) and the contacting pads.



Noise in GMR sensors: SMT noise



Noise in GMR sensors: SMT noise

J.-G. Zhu, *"Current Induced Noise in CPP Spin Valves,"* IEEE Trans. Magn. **40**, 2323 (2004). (Carnegie Mellon & Headway Technologies)



Fig. 5. Integrated resistance noise power as a function of sense current, measured in zero magnetic field. Noise criticality in either current direction is evident.

Also: M. Covington, *"Current-induced magnetization dynamics in current perpendicular to the plane spin valves,"* PRB **69**, 184406 (2004). (Seagate)

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Vortex oscillations in nanopoint contacts

– Fabrication: IMEC

- Characterization: IEF-UPS, IMEC
- Modelling: U.Sheffield, IEF-UPS







Precession: the fast dynamics of the magnetization



<u>Damped precession</u> of the magnetization M around its equilibrium axis

<u>Effective field H_{eff}</u> : all magnetic energies of the system

Precession frequency: $f = f_0 H_{eff}$

 $f_0 = 28 MHz / mT (= 2.8 GHz / kOe)$

natural precession frequencies in the 1–10 GHz range with usual 3d ferromagnetic metals

→ can we overcome damping for applications ?

Spin-torque oscillators

Technical realizations:

"Nano-Pillar"



"Nano-Contact"



- In-plane radius of active area: ≈ 20 200 nm
- "Free" layer thickness: 2 5 nm
- "Fixed" layer thickness: 10 20 nm (pinned with antiferromagnet)
- Current density: $\approx 10^8 10^9 \text{ A/cm}^2$



RF emission from nano-contacts



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RF emission from nano-contacts

a reference measurement



- spin valve stack with ΔR = 140m Ω
- applied field $\mu_0 H = 0.7 T$



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• output voltage: 93 μ V (on 50 Ω load)

in different conditions: lower power but record Q ~18100

W. H. Rippard et al., Phys. Rev. B 70, 100406 (2004)

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Point-contact fabrication



1. Cu bottom electrode

- 2. Spin valve deposition and ion milling (17 x 27 μm)
- 3. Passivation with SiO₂
- 4. E-beam lithography and *wet etching* of point contact and vias
- 5. Top contact definition using metal (Au) lift-off

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Point contact morphology







Point contact morphology



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Magnetic and MR properties



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RF measurements



- Variable < 3.5 kOe in-plane and perpto-plane fields
- Permanent magnets (~ 5 kOe) for large perp. fields



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Low frequency power spectra

Mistral, van Kampen et al., PRL 100, 257201 (2008)



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Vortex oscillations in magnetic dots



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Vortex oscillations in point contacts?



Low frequency power spectra



- Quasi-linear variation with current
- *f*₀: 250-400 MHz

- "Threshold" field for oscillations
- If FMR: *f*₀ ~ 1 GHz

Zero-field oscillations



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(In-)Sensitivity to in-plane fields



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Micromagnetics simulations



$$\mathbf{h} = \mathbf{h}_{\text{exchange}} + \mathbf{h}_{\text{anis}} + \mathbf{h}_{\text{demag}} + \mathbf{h}_{\text{ext}} + \mathbf{h}_{\text{oersted}}$$
$$+ \text{ inhom. J distribution (nanocontact exact profile)}$$



Micromagnetics simulations

Mistral, van Kampen, Hrkac et al., PRL 100, 257201 (2008)

Simulations show vortex orbits outside point contact region





Comparison between simulation and experiment Mistral, van Kampen, Hrkac et al., PRL 100, 257201 (2008)



excellent agreement theory-experiment
 harmonics due to slightly elliptic trajectory (H_κ)

Rigid vortex model

Mistral, van Kampen, Hrkac et al., PRL 100, 257201 (2008)

Seek to explain general trends with analytical model



- Treat vortex as rigid object
- Derive equations of motion with spin-transfer torque

Thiele equation + Slonczewski term

$$ec{G} imes rac{dec{X}_0}{dt} - lpha \, \mathbf{D} \cdot rac{dec{X}_0}{dt} + \sigma I \left(ec{P}_\perp - ec{P}_{||}
ight) = rac{\gamma}{M_s} rac{\partial W}{\partial ec{X}_0}$$
gryoscopic motion damping spin-transfer force

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Rigid vortex model

Mistral, van Kampen, Hrkac et al., PRL 100, 257201 (2008)

Assume vortex is sufficiently far from contact region



Comparison between theory and experiment

Mistral, van Kampen, Hrkac et al., PRL **100**, 257201 (2008)

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Summary: vortex oscillations

- Solid experimental evidence of current-driven vortex oscillations in metallic point-contacts
- < 500 MHz oscillations, tunable with current and perpendicular fields
- Good agreement with simulation and theory

BLS studies on in nanopoint contacts

- Fabrication: IMEC

- Characterization: TUKL

Brillouin light scattering (BLS) process

= inelastic scattering of photons from spin waves

SPINSWITCH

Point contact device geometries

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Device Fabrication

Tip and top electrode overlap Au/Ti top electrodes Uniform Ti/Au layer Insulating SiO₂ Thin film multilayer GaAs substrate Point contact etched into SiO₂

Device Fabrication

E.g. BLS device

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Brillouin Light Scattering Devices: Tip Breakdown

Tip breakdown for high currents (>30 mA)

 \Rightarrow Mechanism? (Does the actual point contact survive?)

Radiation pattern of resonances

Intensity of inelstally scattered light

Characterization of dynamic properties: FMR with BLS-sensor

- constant position
- sweeping AC frequency for different magnetic fields

- Frequency of RF-source [GI

Radiation pattern of resonances

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Nonlinear phenomena

Frequency of RF-source [GHz]

- Constant position close to the point contact
- Sweeping the externally applied ac-frequency
 - Higher frequency generation 2f, 3f, 4f
 - Half frequency generation $\frac{1}{2} f$, $\frac{1}{2} f$

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Nonlinear phenomena

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Nonlinear phenomena and DC current induced effects

 Investigation of the power threshold for nonlinear frequency conversion as function of the DC current

The Resonance mode increases linearly with the applied RF-power
1/2 f shows clearly threshold behavior

Threshold properties depends on internal losses (damping)

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Shift of the power threshold for the 3-magnon scattering probability

Control of the effective damping due to DC-current: Spin torque effect!

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Measure the threshold power dependence as function of the DC current and the X scan position from the point contact

No effect of the scan position on the dependence of the shift of the power threshold for the 3-magnon scattering probability as function of the dc current: Spin torque effect and no effect of the Oersted field (= spatial dependence) ?

Measure the threshold frequency for half frequency generation as function of the DC current and the scan position from the point contact: Know the effect of the spin torque effect or the Oersted field on the shift of dispersion curves

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Measure the threshold frequency for half frequency generation as function of the DC current and the scan position from the point contact:

threshold frequency for $\omega/2$ generation

DC current induced a shift of the threshold frequency for f/2 generation
 No effect of the X scan position (left and right from the point contact) on the threshold frequency dependence as function of the DC current : Spin torque effect and not Oersted field effect! (Oersted field effect = spatial dependence with distance from the point contact)!

Conclusion and perspectives

• Conclusions:

- Dc current induced a shift of the power threshold for the 3magnon scattering probability and the threshold frequency for half frequency mode generation
- control of the effective damping due to DC-current
- No effect of the scan position on the dependence of the threshold properties of 3-magnon scattering decay (power and frequency) as function of the dc current
- \Rightarrow Spin torque effect and no effect of the Oersted field?

Perspectives:

 Understand more the effect of spin torque transfer in nonlinear spin dynamics system

aspire invent achieve

